## IN THE CLAIMS

This listing of claims replaces all prior listings:

1. (currently amended) A testing system comprising:

A self-contained hand-held transmitter including an enclosure and having a plurality of prongs that plug into a receptacle electrically coupled to a selected branch circuit, the transmitter having a circuit within the enclosure that tests an arc fault circuit interrupter electrically coupled to the selected branch circuit by creating a pulse on the branch circuit that trips the arc fault circuit interrupter, the pulse being created by

generating a timing period signal for generating simulated arc fault pulses by calibrating an internally calculated clock rate of a processor based on a received synchronization signal; and

outputting the simulated arc fault pulses at a timing period defined by the timing period signal output by the processor.

wherein the transmitter has a second circuit within the enclosure that tests whether the receptacle is wired properly by indicating whether at least one of a hot wire, a neutral wire, and ground wire of the branch circuit is wired properly based on current flow through at least one of the hot wire, neutral wire, and ground wire.

- 2. (previously presented) The testing system of claim 1, wherein at least a portion of the second circuit that tests whether the receptacle is wired properly is a shared circuit with the circuit that tests the arc fault circuit interrupter.
- 3. (original) The testing system of claim 1, wherein the hand-held transmitter is contained within a single enclosure.
  - 4. (withdrawn) A testing system comprising:

a hand-held transmitter that plugs into a receptacle electrically coupled to a selected branch circuit, the transmitter having a circuit effective to test an arc fault circuit interrupter electrically coupled to the selected branch circuit by creating a first pulse on the branch circuit that is effective to trip the arc fault circuit interrupter,

wherein the transmitter can perform a test of determining a location of a circuit interrupting device electrically coupled to the selected branch circuit by creating a second pulse on the branch circuit that can be sensed by a receiver located proximately to the respective circuit interrupting device and broadly tuned about a frequency of the second pulse.

- 5. (withdrawn) The testing system of claim 4, wherein at least a portion of a circuit for performing the test of determining the location of the circuit interrupting device is common to the circuit effective to test the arc fault circuit interrupter.
- 6. (withdrawn) The testing system of claim 4, wherein the first pulse has a higher current than the second pulse.
- 7. (withdrawn) The testing system of claim 4, wherein the hand-held transmitter is contained within a single enclosure.
  - 8. (withdrawn) A testing system comprising:

a hand-held transmitter that plugs into a receptacle electrically coupled to a selected branch circuit, the transmitter having a circuit effective to test an arc fault circuit interrupter electrically coupled to the selected branch circuit by creating a first pulse on the branch circuit that is effective to trip the arc fault circuit interrupter,

wherein the transmitter can test a ground fault circuit interrupter electrically coupled to the selected branch circuit by creating a second pulse on the selected branch circuit that is effective to trip the ground fault circuit interrupter.

- 9. (withdrawn) The testing system of claim 8, wherein at least a portion of a circuit for testing the ground fault circuit interrupter is common to the circuit effective to test the arc fault circuit interrupter.
- 10. (withdrawn) The testing system of claim 8, wherein the first pulse has a higher current than the second pulse.

- 11. (withdrawn) The testing system of claim 8, wherein the hand-held transmitter is contained within a single enclosure.
  - 12. (withdrawn) An arc fault circuit interrupter tester comprising:

a processor having an internally calculated clock rate, the processor generating a timing period signal for generating simulated arc fault pulses by calibrating the internally calculated clock rate based on a received synchronization signal; and

a switching circuit outputting the simulated arc fault pulses at a timing period defined by the timing period signal.

- 13. (withdrawn) The arc fault circuit interrupter tester of claim 12, wherein the simulated arc fault pulses are effective to trip an arc fault circuit interrupter.
- 14. (withdrawn) The arc fault circuit interrupter tester of claim 12, wherein the simulated arc fault pulses comprise a plurality of pulses of alternating polarity corresponding to alternating positive and negative phases of an AC line voltage applied to the arc fault circuit interrupter.
- 15. (withdrawn) The arc fault circuit interrupter tester of claim 12, wherein the timing period is around 8.3 milliseconds.
- 16. (withdrawn) The arc fault circuit interrupter tester of claim 12, wherein the simulated arc fault pulses have a peak current of greater than 100 amperes.
- 17. (withdrawn) A method for testing an arc fault circuit interrupter, the method comprising:

generating a timing period signal for generating simulated arc fault pulses by calibrating an internally calculated clock rate of a processor based on a received synchronization signal; and outputting the simulated arc fault pulses at a timing period defined by the timing period signal output by the processor.

- 18. (withdrawn) The method of claim 17, wherein the simulated arc fault pulses are effective to trip an arc fault circuit interrupter.
- 19. (withdrawn) The method of claim 17, wherein the simulated arc fault pulses comprise a plurality of pulses of alternating polarity corresponding to alternating positive and negative phases of an AC line voltage applied to the arc fault circuit interrupter.
- 20. (withdrawn) The method of claim 17, wherein the timing period is around 8.3 milliseconds.
- 21. (withdrawn) The method of claim 17, wherein the simulated arc fault pulses have a peak current of greater than 100 amperes.
  - 22. (withdrawn) An arc fault circuit interrupter comprising:

means for generating a timing period signal for generating simulated arc fault pulses by calibrating an internally calculated clock rate of a processor based on a received synchronization signal; and

means for outputting the simulated arc fault pulses at a timing period defined by the timing period signal output by the processor.